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# Thermochromic undoped and Mg-doped VO<sub>2</sub> thin films and nanoparticles: Optical properties and performance limits for energy efficient windows

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Undoped and Mg-doped thermochromic VO<sub>2</sub> films with atom ratios  $z \equiv Mg/(Mg + V)$ of  $0 \le z < 0.21$  were deposited by reactive DC magnetron sputtering onto heated glass and carbon substrates. Elemental compositions were found by Rutherford backscattering spectrometry. Optical constants were determined from transmittance and reflectance measurements and were used for modeling the optical properties of thin films and dilute nanoparticle composite layers below and above the critical temperature for thermochromic switching between a low-temperature infrared transparent state and a high-temperature infrared reflecting or absorbing state. Mgdoped *films* showed superior luminous transmittance  $T_{lum}$  and solar transmittance modulation  $\Delta T_{sol}$  compared to undoped VO<sub>2</sub> films, and both of these parameters could be further enhanced by anti-reflection. VO<sub>2</sub>-containing *nanocomposites* had much larger values of  $T_{lum}$  and  $\Delta T_{sol}$  than VO<sub>2</sub>-based films. Mg-doping was found to erode the properties of the nanocomposites. Approximate performance limits are given on  $T_{lum}$  and  $\Delta T_{sol}$  for thermochromic VO<sub>2</sub> films, with and without Mg doping and antireflection coating, and also for VO<sub>2</sub>-containing dilute nanocomposites.

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#### I. INTRODUCTION

Optical constants were determined for sputter-deposited undoped and Mg-doped thermochromic VO<sub>2</sub> films. These data were used in a comprehensive modeling study on luminous transmittance  $T_{\text{lum}}$  and achievable solar transmittance modulation  $\Delta T_{\text{sol}}$  for different doping levels in films and dilute nanoparticle composites. The overarching goal is to assess VO<sub>2</sub>-based materials for energy efficient fenestration, and the present paper is a sequel to earlier ones.<sup>1-10</sup>

Vanadium dioxide is a well known thermochromic material.<sup>11</sup> It undergoes a first-order metal-to-insulator transition, accompanied by a crystal structure transformation from monoclinic (M<sub>1</sub>) to tetragonal rutile, at a critical temperature  $\tau_c \approx 68$  °C. Below this temperature, at  $\tau < \tau_c$ , VO<sub>2</sub> is semiconducting and infrared transmitting, whereas it is metallic and infrared reflecting at  $\tau > \tau_c$ . As  $\tau_c$  is rather close to room temperature, VO<sub>2</sub>-based materials are of interest for applications on energy efficient windows,<sup>12–19</sup> specifically for passively modulating the solar energy throughput depending on temperature. The potential energy saving can be high, especially in warm climates.<sup>20–22</sup> However VO<sub>2</sub> needs a number of modifications in order to be useful in practical windows-related applications: thus  $\tau_c$  should be lowered to room temperature, and  $T_{\text{lum}}$  as well as  $\Delta T_{\text{sol}}$  should be enhanced.<sup>7</sup>

Doping is a well-established way to decrease  $\tau_c$ ,<sup>23</sup> with tungsten as the superior dopant capable of reducing  $\tau_c$  by as much as ~25 °C/at.% W for well-crystallized films, made by a variety of techniques,<sup>7</sup> without severely deteriorating the optical performance.<sup>24</sup> Magnesium doping was found to be able to increase  $T_{lum}$  and to simultaneously decrease  $\tau_c$  by ~3 °C/at.% Mg;<sup>1,25</sup> the boost in optical performance was seen to be connected with band gap widening and concomitant lowering of the spectral absorptance in the luminous wavelength range.<sup>8,10</sup> These features could be reconciled with hybrid functional calculations.<sup>10</sup> Fluorine doping is another way to enhance  $T_{lum}$ .<sup>26-29</sup> Furthermore, antireflection (AR) coatings are able to improve  $T_{lum}$  and  $\Delta T_{sol}$ , and especially good properties have been reported for five-layer coatings of alternating TiO<sub>2</sub> and VO<sub>2</sub>.<sup>2,3</sup>

Recent modeling studies on "nanothermochromics"<sup>4,5</sup> have shown that VO<sub>2</sub> nanoparticles can offer significantly higher values of  $T_{\text{lum}}$  and  $\Delta T_{\text{sol}}$  than films, and these new possibilities have led to a burst of research on such nanoparticles.<sup>6,9,19,22,25,30–34</sup> Doped VO<sub>2</sub> nanoparticles are of interest since they may be able to yield reduced values of  $\tau_c$ , and Mg-doped VO<sub>2</sub> nanoparticles have demonstrated a potential for improving  $T_{\text{lum}}$  although with some depression of  $\Delta T_{\text{sol}}$ .<sup>25</sup>

This paper is outlined as follows: Section II reports on the samples and treats sputter deposition, compositional and structural data, and optical characterization and properties; this section also contains a discussion of sample quality which—as found in recent work of ours<sup>9</sup>—may be critically dependent on several aspects of the thin film preparation. Section III contains results and discussions for undoped and Mg-doped VO<sub>2</sub> thin films without and with AR coatings as well as for nanoparticle composites containing the same VO<sub>2</sub>-based materials. Section IV, finally, summarizes the main findings and presents them in a pictorial way that allows a straight forward comparison of several different types of VO<sub>2</sub>-based materials with regard to their potential applicability in energy efficient fenestration.

#### **II. SAMPLE PREPARATION AND CHARACTERIZATION**

#### A. Sputter deposition

Thin films of Mg-doped and pure VO<sub>2</sub> were prepared on glass and carbon substrates by reactive DC magnetron sputtering in a deposition system based on a Balzers UTT 400 unit. The chamber was initially pumped down to  $6.3 \times 10^{-7}$  mbar, and 80 ml/min of argon and 5 ml/min of oxygen (both 99.997%) were then introduced through mass-flow-controlled gas inlets so that the total pressure was maintained at  $1.2 \times 10^{-2}$  mbar during the deposition. Cosputtering was performed from 5-cm-diameter targets of vanadium (99.5%) at a power of 172 W and Mg (99.9%) at a power of 0 to 57 W onto substrates kept at ~450 °C. Clamps were used to ensure good mechanical contact between substrates and heater. More than forty samples were grown to thicknesses in the range 40 < d < 100 nm at a rate of ~0.06 nm/s. The value of *d* was measured with a Bruker DektakXT profilometer and was further confirmed with optical analysis. Some of the as-deposited samples displayed metallic-like properties and were post-annealed at 450 °C in an oxygen atmosphere of  $1.3 \times 10^{-2}$  mbar for 15 to 60 min.

## B. Compositional and structural characterization

The elemental compositions of samples deposited on carbon substrates were evaluated using Rutherford backscattering spectrometry (RBS) with 2 MeV <sup>4</sup>He ions backscattered at an angle of 170°. Data were then extracted from analyses based on iterative least-square fitting to

experimental spectra by use of the SIMNRA program.<sup>35</sup> Two examples of this evaluation are shown in Fig. 1. The various samples were found to have atom ratios  $z \equiv Mg/(Mg + V)$  in the interval  $0 \le z < 0.21$ . Eight samples contained Si and were excluded from the analysis in the present work but were discussed elsewhere.<sup>8</sup> Film density  $\rho$  was evaluated from RBS data and *d*.

Nanostructural information was obtained by scanning electron microscopy (SEM) using a LEO 1550 FEG Gemini instrument with an acceleration voltage of 5 to 15 kV and using an in-lens detector. Figure 2 shows characteristic data for films with two values of z. A SEM image of an undoped VO<sub>2</sub> film was reported before.<sup>9</sup>

#### C. Optical characterization techniques and properties

Spectral and temperature-dependent normal transmittance  $T(\lambda,\tau)$  and near-normal reflectance from the surface side  $R_s(\lambda,\tau)$  and back side  $R_b(\lambda,\tau)$  of the samples were measured using a single-beam spectrophotometer devised for absolute measurements<sup>36</sup> and a Perkin– Elmer Lambda 900 double-beam spectrophotometer equipped with a BaSO<sub>4</sub>-coated integrating sphere. Data were recorded in the wavelength range 300 <  $\lambda$  < 2500 nm, encompassing luminous light at 400 <  $\lambda$  < 700 nm and near-infrared (NIR) radiation at 700 <  $\lambda$  < 2500; measurements were performed at room temperature and ~100 °C. Optical constants *n* and *k* were obtained by simulating the complex dielectric functions  $\varepsilon = \varepsilon_1 + i\varepsilon_2$  with oscillator models and fitting the experimental data on  $R_s$ ,  $R_b$  and *T* to calculated spectra using commercial software.<sup>37</sup> A similar approach has been used in earlier work.<sup>8,9,38</sup> Some of the samples had too large surface roughness to give satisfactory fits under the constraints imposed by this analysis and are not considered below. The optical constants for the remaining 22 samples were obtained from

$$\boldsymbol{n} = \left[\frac{1}{2}((\varepsilon_1^2 + \varepsilon_2^2)^{1/2} + \varepsilon_1)\right]^{1/2}, \qquad (1)$$

$$\boldsymbol{k} = \left[\frac{1}{2}((\varepsilon_1^2 + \varepsilon_2^2)^{1/2} - \varepsilon_1)\right]^{1/2}.$$
(2)

Figure 3 shows experimental and fitted spectra for five samples, which are discussed in detail below, whose values of z, d and  $\rho$  are given in Table I. The samples exhibit typical behavior of VO<sub>2</sub>-based films: the semiconducting state shows high transparency in the NIR, as seen in Fig. 3(c), and the metallic state has a reflectance that rises monotonically for increasing wavelength in the NIR as shown in Figs. 3(d) and (e), except for the sample with z

= 0.088. By comparing the reflectance in the semiconducting state [Figs. 3(a) and (b)] and metallic state [Figs. 3(d) and (e)], one can notice that the reflectance modulation in the NIR is smaller for Mg-doped VO<sub>2</sub> films than for undoped VO<sub>2</sub> films. It is also apparent that the onsets of transmittance shift towards shorter wavelengths when the Mg doping is large.

Data of the kind reported in Fig. 3 were used to extract optical constants for undoped and Mgdoped VO<sub>2</sub> films at  $\tau < \tau_c$  and  $\tau > \tau_c$ , as reported in Fig. 4. For the semiconducting state (Fig. 4a), *n* and *k* curves show similar trends for all Mg contents. The data are rather wavelengthindependent in the NIR, except for the very broad maximum around ~1000 nm in the case of *k*. The peak in *k* at the shortest wavelengths signifies the strong optical absorption due to inter-band transitions at the band gap energy  $E_g$ , where  $1.6 < E_g < 2.6 \text{ eV}$ .<sup>8,10</sup> The value of *k* for luminous light, as well as the level of the plateau in the NIR data for *n*, shows a tendency to decrease for Mg-doped VO<sub>2</sub> films, but it is difficult to ascertain a systematic relationship. For the metallic state (Fig. 4b), it can be seen that *k* increases with increasing wavelength in the NIR, and the same is true for *n* at  $\lambda > 1000$  nm. In the case of undoped VO<sub>2</sub>, *k* exhibits a marked metallic behavior and surpasses the value of *n* for  $\lambda > 1100$  nm. The metallic feature is weaker in Mg-doped VO<sub>2</sub>, which can be reconciled with the reflectance data in the metallic state shown in Figs. 3(d) and (e). Our results for undoped VO<sub>2</sub> films are consistent with literature data,<sup>3,24,39-41</sup> as shown in detail elsewhere.<sup>9</sup>

It can be inferred from Fig. 3 and Table I that *n* and  $\rho$  are correlated. Evaluations performed for  $\lambda$  being 550, 1000 and 2500 nm showed an approximate linear relationship according to

$$n = \kappa + \zeta \rho, \tag{3}$$

with  $\kappa = 1.2 \pm 0.1$  and  $\zeta \sim 0.32 \text{ m}^3/\text{kg}$ .

#### D. On sample quality and reproducibility

It is evident from the optical data in Figs. 3 and 4 that substantial scattering exists for VO<sub>2</sub>-based thin films with nominally the same composition and deposited with similar parameters. This observation leads to considerations of sample quality and reproducibility, which clearly are of great importance and—in our opinion—have not received sufficient attention in most prior work. These issues were addressed, however, in a recent study of ours whose main goal was to elucidate the growth conditions for sputter deposited VO<sub>2</sub> films and nanorods.<sup>9</sup> Five different deposition parameters were identified and found to be crucial:

(*i*) The geometry for inlet of the reactive gas during sputter deposition affected the roughness and grain structure of the films. In the present work we used conditions denoted (a) in our earlier study,<sup>9</sup> which were then found to lead to compact films with a density that was about 11% lower than the bulk value for VO<sub>2</sub>. The critical importance of the oxygen partial pressure and flow rate has been demonstrated repeatedly in earlier work.<sup>42–46</sup>

(*ii*) The film thickness was important, and a large value of d promoted the formation of surface nanostructures, as also seen elsewhere.<sup>47,48</sup> More generally, the surface of a VO<sub>2</sub> film may be different from its main part<sup>49</sup> and the same may be true for the substrate/film interface.<sup>50</sup>

(*iii*) The substrate temperature during deposition played a role, as found also by others,  $^{51-53}$  and a high value could lead to surface nanofeatures.

(iv) Substrate roughness promoted the development of film roughness.

(v) Seed layers could yield pronounced nanostructures, as investigated in detail for the case of gold seeds in the earlier investigation<sup>9</sup> where they were found to lead to nanorod formation.

For the present work, one should also consider the role of Mg doping as a potential source for influencing the growth of VO<sub>2</sub>-based films. Another factor affecting the reproducibility may be thermal stress induced in the film during deposition and subsequent cooling.<sup>54, 55</sup>

Considering these uncertainties, it may not be surprising that our samples show significant scattering in their optical properties, despite our sustained efforts to prepare the films under as stringent process control as possible. The data encapsulated in Eq. (3) are interesting in this context and point at the significance of porosity across the entire VO<sub>2</sub>-based films rather than a dominating influence of surface roughness. In order to compensate for the limited sample reproducibility, we investigated a sufficiently large number of samples in order to reach trustworthy results and conclusions.

#### **III. OPTICAL MODELING: RESULTS AND DISCUSSION**

Thin films and nanoparticle composite layers were characterized in terms of their wavelength-integrated luminous and solar transmittance. These properties were obtained from

$$T_{\text{lum,sol}}(\tau) = \int d\lambda \ \varphi_{\text{lum,sol}}(\lambda) \ T(\lambda,\tau) / \int d\lambda \ \varphi_{\text{lum,sol}}(\lambda) \ , \tag{4}$$

where  $\varphi_{\text{lum}}$  is the spectral sensitivity of the light-adapted human eye<sup>56</sup> and  $\varphi_{\text{sol}}$  is the solar irradiance spectrum for air mass 1.5 (the sun at 37° above the horizon).<sup>57</sup> The thermochomic performance, and its relevance for energy efficient fenestration, was specified by  $T_{\text{lum}}$  for  $\tau < \tau_c$  and  $\tau > \tau_c$ ,  $T_{\text{sol}}$  for  $\tau < \tau_c$  and  $\tau > \tau_c$ , and  $\Delta T_{\text{sol}}$  defined by

$$\Delta T_{\rm sol} \equiv T_{\rm sol}(\tau < \tau_c) - T_{\rm sol}(\tau > \tau_c) \quad . \tag{5}$$

## A. Thin films

Calculations based on Fresnel's equations<sup>58</sup> were used to derive  $T(\lambda,\tau)$  for VO<sub>2</sub>-based thin films with 0 < d < 200 nm and backed by glass plates characterized by a refractive index 1.5. The input data were our optical constants for all 22 samples, some of which were shown in Fig. 4.

Figure 5 shows data for a fixed film thickness of 50 nm. The influence of Mg-doping is illustrated for  $T_{\text{lum}}(\tau < \tau_c)$ ,  $T_{\text{lum}}(\tau > \tau_c)$  and  $\Delta T_{\text{sol}}$  in panels (a), (b) and (c), respectively. The values of  $T_{\text{lum}}$ , reported in panels (a) and (b), show a general tendency to increase for increasing amount of Mg, although there is significant scattering among the data points especially for small doping levels. Concerning  $\Delta T_{\text{sol}}$ , Fig. 5(c) indicates a decreasing trend as z is increased. These findings are in good agreements with literature data<sup>1,25</sup> showing that  $T_{\text{lum}}$ and  $\Delta T_{\text{sol}}$  display opposite trends with regard to Mg-doping. In particular, the band gap widening that occurs gradually for increasing z leads to a boost in  $T_{\text{lum}}$ .

The lowering of the luminous absorption in Mg-doped VO<sub>2</sub> films indicates that they may outperform undoped VO<sub>2</sub> films for both  $T_{\text{lum}}$  and  $\Delta T_{\text{sol}}$  if given a judicious choice of thickness. The effect of film thickness in the  $0 \le d \le 200$  nm interval is elucidated in Fig. 6, where panels (a) and (b) refer to  $T_{\text{lum}}(\tau \le \tau_c) vs \Delta T_{\text{sol}}$  and  $T_{\text{lum}}(\tau > \tau_c) vs \Delta T_{\text{sol}}$ , respectively. All curves start at the top left of the figure with d = 0,  $\Delta T_{\text{sol}} = 0$  and  $T_{\text{lum}} \approx 92\%$  and proceed to the bottom right with d = 200 nm. For clarity, the data are categorized in four groups according to Mg content: z = 0,  $0 \le z \le 0.06$ ,  $0.06 \le z \le 0.11$ , and  $0.11 \le z \le 0.21$ .

We first consider data for undoped VO<sub>2</sub>. Requiring  $\Delta T_{sol} > 5\%$  leads to  $T_{lum}$  around 40% or less, and demanding  $\Delta T_{sol} > 10\%$  forces  $T_{lum}$  to be smaller than ~30%. Such a moderate thermochromic performance is typically expected with undoped VO<sub>2</sub> films, although the detailed numbers can vary somewhat depending on the individual set of *n* and *k* chosen for analysis. It is hence clear that it is desirable to seek means to improve VO<sub>2</sub> films.

Among the data for Mg-doped VO<sub>2</sub> films, those for 0.11  $\leq z \leq 0.21$  show poor performance, and these "overdoped" samples are not considered further. The remaining samples follow the same trend irrespectively of being semiconducting or metallic: there is an initial rapid drop of  $T_{\text{lum}}$ , which is particularly abrupt for  $\Delta T_{\text{sol}}$  being 2 to 4%, followed by another less pronounced drop of  $T_{\text{lum}}$  when  $\Delta T_{\text{sol}}$  is around 8 to 10%. For solar modulations between these two intervals, it is seen that  $T_{\text{lum}}$  remains rather unchanged. The reason for this constancy is to be found in optical interference, and it appears that destructive interference lowers the reflectance to more or less balance out the increased optical absorption associated with the larger film thickness. Another important observation from Fig. 6 is that the data for the great majority of the Mg-doped VO<sub>2</sub> films lie to the upper right of the data for pure VO<sub>2</sub>, implying that Mg doping leads to a significant enhancement of  $T_{\text{lum}}$  and  $\Delta T_{\text{sol}}$ . One can also draw the provisional conclusion that the best samples have z < 0.06. Specifically requiring  $\Delta T_{\text{sol}} = 10\%$ , which may be a performance limit for practically useful thermochromic fenestration, one can achieve  $T_{\text{lum}}(\tau < \tau_c) \approx 45\%$  and a slightly lower value at  $\tau > \tau_c$ , whereas an undoped VO<sub>2</sub> film only yields  $T_{\text{lum}} \sim 30\%$  at best.

#### B. Thin films with antireflection coatings

AR coatings can improve  $T_{lum}$  and  $\Delta T_{sol}$ , as is well known, and studies have been reported for SiO<sub>2</sub>/VO<sub>2</sub>,<sup>59-62</sup> TiO<sub>2</sub>/VO<sub>2</sub>,<sup>18,61,63</sup> ZrO<sub>2</sub>/VO<sub>2</sub>,<sup>64</sup> SiO<sub>x</sub>/VO<sub>2</sub>/SiO<sub>x</sub>,<sup>40</sup> TiO<sub>2</sub>/VO<sub>2</sub>/TiO<sub>2</sub>,<sup>2,3,65</sup> and TiO<sub>2</sub>/VO<sub>2</sub>/TiO<sub>2</sub>/VO<sub>2</sub>/TiO<sub>2</sub>.<sup>2,3</sup> Infrared-optical properties have been optimized in films of ITO/VO<sub>2</sub> and ITO/VO<sub>2</sub>/ITO.<sup>66</sup> An AR coating can serve also to prevent the oxidation of VO<sub>2</sub>, as shown for base layers of TiO<sub>2</sub> (Ref. 67) and top layers of CeO<sub>2</sub> (Ref. 68) and Al<sub>2</sub>O<sub>3</sub>,<sup>69</sup> and also to lower the thermal emittance as found for ZnO:Al/VO2.<sup>70</sup> A survey of earlier work has been given in the literature.<sup>19</sup> We investigated the effect of AR coatings with thicknesses in the range  $0 < d_{AR} < 300$  nm, characterized by a refractive index  $n_{AR} = 1.5$  (typical for SiO<sub>2</sub> and many polymers), positioned on top of VO<sub>2</sub>-based films with different values of z and d as specified in the first two columns in Table II. The outcomes of the calculations were visualized as trajectories in plots of  $T_{lum}(\tau < \tau_c)$  vs  $\Delta T_{sol}$  and  $T_{lum}(\tau > \tau_c)$  vs  $\Delta T_{sol}$ , as shown in Fig. 7. It is apparent that  $T_{\text{lum}}$  and  $T_{\text{sol}}$  vary significantly when  $d_{\text{AR}}$  is changed, and that there are particular magnitudes of  $d_{AR}$  that yield favorable combinations of these parameters. We selected the points indicated by circles in Fig. 7, which correspond to the values of  $d_{AR}$  in the third column in Table II. Clearly this technique involves some degree of subjectivity but was deemed appropriate for giving a good overall picture of the improvements of the optical properties that are feasible with AR coatings. Calculations were also done for  $n_{AR} = 2.1$ ,

which is typical for sputter-deposited TiO<sub>2</sub> films.<sup>71</sup> However, the results were not significantly better than those for  $n_{AR} = 1.5$  and are not further discussed here.

Table II shows data from the computations. It is evident that AR treatments can significantly improve  $T_{\text{lum}}$  by up to ~8% in absolute value, while adding 2 to 3% to  $\Delta T_{\text{sol}}$ . A well-chosen set of parameters can offer  $\Delta T_{\text{sol}} = 9.2\%$ , with  $T_{\text{lum}}(\tau < \tau_c)$  and  $T_{\text{lum}}(\tau > \tau_c)$  reaching 59.3% and 57%, respectively. Alternatively, one can push  $\Delta T_{\text{sol}}$  to 12.8% and maintain  $T_{\text{lum}}(\tau < \tau_c)$  and  $T_{\text{lum}}(\tau > \tau_c)$  at 47.5% and 44%, respectively. Even higher solar modulation, with  $\Delta T_{\text{sol}} = 15.4\%$ , is achievable but at the expense of having  $T_{\text{lum}} \sim 30\%$ .

The results in Table II are consistent with the best data for TiO<sub>2</sub>/VO<sub>2</sub> films in the literature, reported recently by Chen *et al.*<sup>61</sup> who found  $\Delta T_{sol} \approx 15\%$  together with  $T_{lum}(\tau < \tau_c)$  and  $T_{lum}(\tau > \tau_c)$  being 49.5% and 45%, respectively.

#### C. Nanothermochromics: VO<sub>2</sub> nanospheres embedded in a dielectric medium

The modeling considers VO<sub>2</sub> nanoparticles embedded in a glass or polymer-like dielectric medium characterized by the dielectric constant  $\varepsilon_m = 2.25$  (refractive index 1.5). The optical properties of such a composite layer can be described with effective medium theory, assuming nanoparticle sizes that are much smaller than the wavelength. In the same manner as in earlier work,<sup>4,72,73</sup> we derive an effective dielectric function  $\varepsilon^{MG}$  from Maxwell–Garnett theory<sup>74</sup> according to

$$\varepsilon^{MG} = \varepsilon_m \frac{1 + \frac{2}{3} f\alpha}{1 - \frac{1}{3} f\alpha} , \qquad (5)$$

where *f* represents the filling factor (*i.e.*, volume fraction) of VO<sub>2</sub> particles and is taken to be 0.01 for the dilute material of present interest. The parameter  $\alpha$  is given for spherical particles by

$$\alpha = \frac{\varepsilon_p - \varepsilon_m}{\varepsilon_m + \frac{1}{3}(\varepsilon_p - \varepsilon_m)} \quad , \tag{6}$$

where  $\varepsilon_p$  is the dielectric function of the VO<sub>2</sub> particles. VO<sub>2</sub> has an exceptionally small mean free path,<sup>75–78</sup> which is not large enough to impart any particle size dependence, and hence it is appropriate to use the dielectric functions obtained from films as input data for  $\varepsilon_p$ . Finally  $\varepsilon^{MG}$  for VO<sub>2</sub>-based films with different Mg contents was used as an input for computations of  $T(\lambda,\tau)$  and  $R(\lambda,\tau)$  for layers comprising nanoparticle composites. These calculations used Fresnel's equations in the same way as for films. The layer thickness for the nanocomposites was varied in the  $0 < d_{nc} < 20 \ \mu$ m range to enable comparison with data for films containing the same amount of VO<sub>2</sub>-based material and shown above.

Figure 8 reports data for a fixed layer thickness of 5  $\mu$ m in the same way as for the 50nm-thick films in Fig. 5. It is evident from panels (a) and (b) that  $T_{\text{lum}}(\tau < \tau_c)$  and  $T_{\text{lum}}(\tau > \tau_c)$ both rise for increasing values of *z* although there is a significant amount of scattering of data for nanocomposites containing metallic VO<sub>2</sub>-based particles. It is noteworthy that all of the transmittance values exceed 55%, *i.e.*, they are much larger than the corresponding values shown in Fig. 5. Data on  $\Delta T_{\text{sol}}$ , reported in Fig. 8(c), show that this parameter is two to three times larger than in films, and it is also apparent that  $\Delta T_{\text{sol}}$  drops for increasing Mg contents. The results in Fig. 8 are in line with earlier findings<sup>4</sup> that the values of  $T_{\text{lum}}$  and  $\Delta T_{\text{sol}}$  are much higher for nanoparticle composites than for thin films. It is apparent that  $T_{\text{lum}}$  and  $\Delta T_{\text{sol}}$  exhibit opposite trends for increasing Mg contents.

Figure 9 shows the effect of layer thicknesses in the  $0 < d_{nc} < 20 \ \mu m$  range for  $T_{lum}(\tau < \tau_c)$ vs  $\Delta T_{sol}$  and  $T_{lum}(\tau < \tau_c)$  vs  $\Delta T_{sol}$  in panels (a) and (b), respectively. This figure allows a direct comparison with data for thin films in Fig. 6. It is evident that the general picture regarding nanoparticle-containing layers is very different from the one for thin films, and the layers with nanoparticles of undoped VO<sub>2</sub> in general outperform the layers with Mg-doped VO<sub>2</sub>. Specific data for two different layers are given in Table III in order to allow comparisons with results for AR-coated VO<sub>2</sub>-based films in Table II.

The superior performance of the nanocomposite layers should be underscored and, for example, Fig. 9 shows that  $T_{sol} = 10\%$  can be obtained with  $T_{lum}(\tau < \tau_c) \sim 82\%$  and  $T_{lum}(\tau > \tau_c) \sim 77.5\%$ , whereas films then have  $T_{lum} < 35\%$ , and that a value of  $T_{sol}$  as large as 20%—which is unattainable for films—can be reached with  $T_{lum}(\tau < \tau_c) \sim 66\%$  and  $T_{lum}(\tau > \tau_c) \sim 57\%$ .

The reason for the qualitative difference between nanoparticle composite layers and thin films can be unraveled from calculations of  $T(\lambda,\tau)$  and  $R(\lambda,\tau)$ , as reported in Fig. 10 for layers incorporating nanoparticles of undoped and Mg-doped VO<sub>2</sub> with z = 0.055 and having the thicknesses 1, 3, and 10  $\mu$ m. Three things deserve attention and explain the superior performance of the undoped VO<sub>2</sub> nanoparticles: (*i*) the optical properties for luminous light are similar for the two types of materials, and Mg doping does not seem to offer any significant advantage, (*ii*) the positive influence of optical interference manifested in the films is absent in the nanoparticle composite layers, and (*iii*) the plasmon resonance in the NIR is largest in pure VO<sub>2</sub>, which follows from its stronger metallic behavior, so that the modulation of the absorption is then strongest at  $\tau_c$ . The net effect is that the larger value of  $\Delta T_{sol}$  for undoped VO<sub>2</sub> outweighs the increase of  $T_{lum}$  by Mg-doping in the case of dilute nanoparticle composites.

#### **IV. SUMMARY AND CONCLUSION**

This study has offered a comprehensive view on thermochrome VO<sub>2</sub>-based materials with regard to applications in energy efficient windows. We sputter deposited undoped and Mg-doped VO<sub>2</sub> films and determined their optical constants, which were subsequently used in model computations for optical properties of undoped and Mg-doped VO<sub>2</sub> films and dilute nanoparticle composite layers with different thicknesses. It was found from computational results that Mg-doped VO<sub>2</sub> films with Mg/(Mg + V) < 0.06 and judiciously chosen thicknesses can have much improved luminous transmittance and solar energy modulation than pure VO<sub>2</sub> films. The addition of single-layer anti-reflection coatings on the top of the VO<sub>2</sub>-based films was shown to further enhance the performance of Mg-doped films. Modeling of nanoparticle composites suggested that undoped VO<sub>2</sub> nanoparticles are more favorable than Mg-doped ones.

Figure 11 gives a pictorial description of the results of our investigation and delineates values of  $T_{\text{lum}}(\tau < \tau_c)$  and  $\Delta T_{\text{sol}}$  that are achievable with different VO<sub>2</sub>-based materials. Various ranges—whose boundaries should not be understood as written in stone—are given for films of undoped and Mg-doped VO<sub>2</sub> without and with a single antireflection coating, and also for nanoparticle composites containing undoped and Mg-doped nanospheres. Non-spherical nanoparticle shapes as well as core-shell structures may improve the performance marginally<sup>4,5</sup> but will not lead to any significant change of Fig. 11. Multilayer structures incorporating more than one VO<sub>2</sub>-layer are not encompassed by Fig. 11 and, as shown for TiO<sub>2</sub>/VO<sub>2</sub>/TiO<sub>2</sub>/TiO<sub>2</sub> films with optimized thicknesses,<sup>2,3</sup> can show a performance that is better than for a single undoped and antireflected VO<sub>2</sub> film, and still better data may be expected for structures containing more than one doped VO<sub>2</sub> film. However, these possible refinements will not alter the overriding result for VO<sub>2</sub>-based materials, namely that nanoparticle composites are superior to films.

# ACKNOWLEDGEMENTS

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Mg/(Mg + V)	Film thickness (nm)	Film density (10 <sup>3</sup> kg/m <sup>3</sup> )
0	64.5	4.5
0.006	61	2.9
0.024	40	4.9
0.055	49.5	2.9
0.088	79.3	3.6

TABLE I. Data on Mg/(Mg + V) atom ratio, film thickness and film density for samples reported on in Figs. 3 and 4.

TABLE II. Luminous transmittance  $T_{lum}$ , for temperatures below and above the critical temperature  $\tau_c$ , and solar energy transmittance modulation  $\Delta T_{sol}$  for thermochromic Mg-doped VO<sub>2</sub> films with the shown Mg content and thickness *d*. Data are reported after application of an antireflection coating with the thickness  $d_{AR}$  as well as in the absence of antireflection (numbers in parenthesis). Highlighted parameter values are discussed in the main text.

Mg/(Mg + V)	d (nm)	d <sub>AR</sub> (nm)	$\Delta T_{ m sol}$ (%)	$T_{\text{lum}}(\tau < \tau_c)$ (%)	$T_{\rm lum}(\tau > \tau_c)$ (%)
0	70	265	11.6 (8.4)	45.3 (35.1)	41.5 (32.8)
0.006	90	260	<b>9.2</b> (7.3)	<b>59.3</b> (50.7)	<b>57</b> (49.7)
0.024	80	265	12.4 (9.3)	44.6 (36.6)	39 (31.6)
0.055	110	265	<b>12.8</b> (10.4)	<b>47.5</b> (42.5)	<b>44</b> (39.4)
0.055	147.5	95	14.4 (12.3)	37 (30.2)	33.2 (29.7)
0.055	147.5	155	15.4 (12.3)	32.1 (30.2)	29.8 (29.7)

TABLE III. Luminous transmittance  $T_{lum}$ , for temperatures below and above the critical temperature  $\tau_c$ , and solar energy transmittance modulation  $\Delta T_{sol}$  for nanoparticle composite layers with the thickness  $d_{nc}$  and containing 1 vol.% of thermochromic Mg-doped VO<sub>2</sub> nanoparticles having the shown Mg content. Results for undoped VO<sub>2</sub> represent averages of the data for two samples.

Mg/(Mg + V)	$d_{nc}$ ( $\mu$ m)	$\Delta T_{\rm sol}$ (%)	$T_{\text{lum}}(\tau < \tau_c)$ (%)	$T_{\text{lum}}(\tau > \tau_c)$ (%)
0	1	4.6	87.8	86
0	5	16.8	72.4	65.2
0	10	23.7	57	46.5
0.055	1	3.0	88.5	87.4
0.055	5	11.9	75	70.4
0.055	10	18.4	61.2	54

#### **Figure Captions**

FIG. 1. Experimental and simulated RBS spectra for VO<sub>2</sub>-based films with the shown Mg/(Mg + V) atom ratios. Insets show magnified data due to Mg. Evidence was found for MgO layers on top of the VO<sub>2</sub>-based films and/or in between these films and their substrates; these layers in general had a combined thickness that was less than 2% of the total film thickness and are considered insignificant for the compositional analysis.

FIG. 2. SEM images of VO<sub>2</sub>-based films with the shown Mg/(Mg + V) atom ratios. Panels (a) and (c) are top views and panels (b) and (d) were imaged at  $70^{\circ}$  between electron beam and surface normal.

FIG. 3. Experimental and calculated spectral optical data for undoped and Mg-doped thermochromicVO<sub>2</sub> films with the shown Mg/(Mg + V) atom ratios. Reflectance from the surface-coated side and the back side, as well as transmittance, are reported as indicated in the various panels. Upper and lower panels refer to films in semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 4. Optical constants, *n* and *k*, of undoped and Mg-doped thermochromic VO<sub>2</sub> films with the shown Mg/(Mg+V) atom ratios. Panels (a) and (b) show data for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 5. Luminous transmittance  $T_{\text{lum}}$  (panels a and b) and solar energy transmittance modulation  $\Delta T_{\text{sol}}$  (panel c) for 50-nm-thick films of undoped and Mg-doped thermochromic VO<sub>2</sub> with the shown Mg/(Mg+V) atom ratios. Panels (a) and (b) show results for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 6. Luminous transmittance  $T_{\text{lum}} vs$  solar energy transmittance modulation  $\Delta T_{\text{sol}}$  for films of undoped and Mg-doped thermochromic VO<sub>2</sub> films with the shown Mg/(Mg+V)  $\equiv z$  atom ratios and having film thicknesses from zero to 200 nm. Panels (a) and (b) show results for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 7. Luminous transmittance  $T_{\text{lum}}$  vs solar energy transmittance modulation  $\Delta T_{\text{sol}}$  for films of undoped and Mg-doped thermochromic VO<sub>2</sub> films with Mg/(Mg+V) atom ratios and film thicknesses d given in Table II. The curves evolved from the point marked with an triangle as the thickness  $d_{\text{AR}}$  of an antireflection layer went from zero to 300 nm. Data are shown for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively. Circles indicate data points corresponding to values of  $d_{\text{AR}}$ ,  $T_{\text{lum}}$ and  $\Delta T_{\text{sol}}$  given in Table II.

FIG. 8. Luminous transmittance  $T_{\text{lum}}$  (panels a and b) and solar energy transmittance modulation  $\Delta T_{\text{sol}}$  (panel c) for 5- $\mu$ m-thick nanocomposite layers containing 1 vol.% of undoped and Mg-doped thermochromic VO<sub>2</sub> with the shown Mg/(Mg+V) atom ratios. Panels (a) and (b) show results for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 9. Luminous transmittance  $T_{\text{lum}} vs$  solar energy transmittance modulation  $\Delta T_{\text{sol}}$  for nanocomposite layers containing 1 vol.% of undoped and Mg-doped thermochromic VO<sub>2</sub> with the shown Mg/(Mg+V) atom ratios and having nanoparticle composite thicknesses from zero to 20  $\mu$ m. Panels (a) and (b) show results for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG 10. Spectral transmittance *T* and reflectance *R* for nanocomposite layers containing 1 vol.% of undoped and Mg-doped thermochromic VO<sub>2</sub> with the shown Mg/(Mg+V) atom ratio and having the stated thicknesses. Panels (a) and (b) show results for semiconducting ( $\tau < \tau_c$ ) and metallic ( $\tau > \tau_c$ ) states, respectively.

FIG. 11. Schematic illustration of achievable performance limits of the shown VO<sub>2</sub>-based materials with regard to thermochromic fenestration for energy efficient buildings. Specifically shown are luminous transmittance  $T_{\text{lum}}$  at low temperature and solar energy transmittance modulation  $\Delta T_{\text{sol}}$  for thin films—including antireflection (AR) coated ones—and dilute nanoparticle composites.

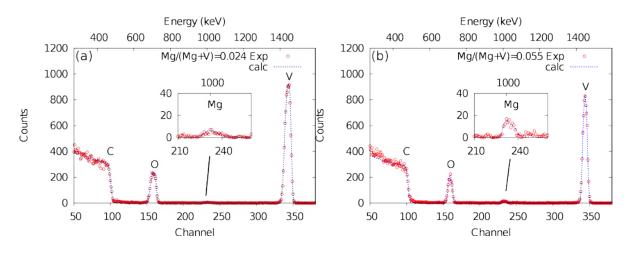


FIG. 1.

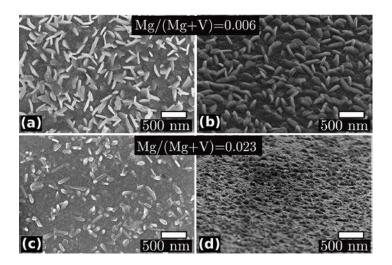


FIG. 2.

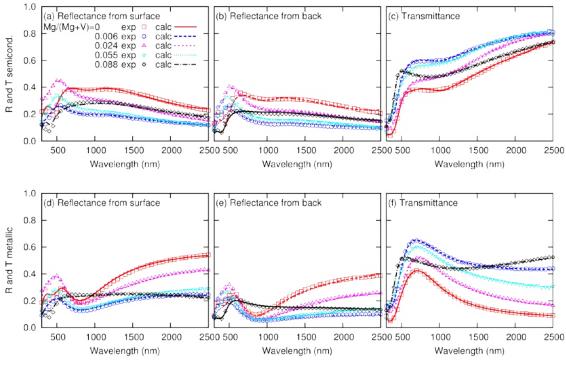
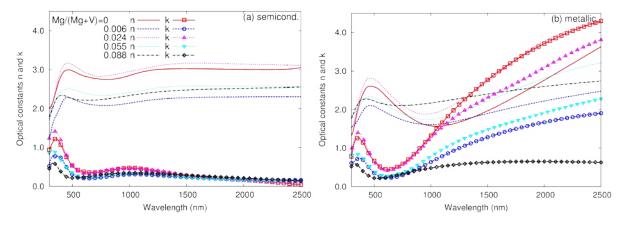
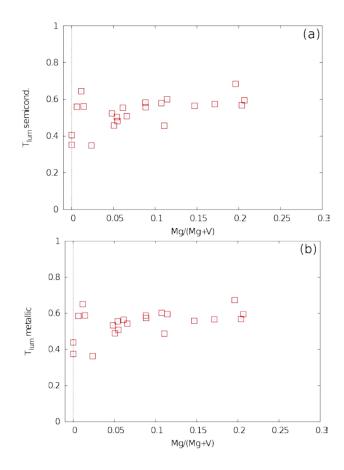


FIG. 3.







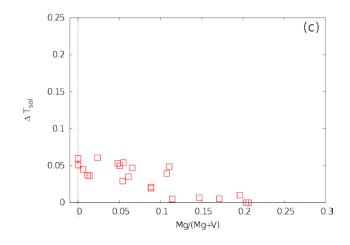


FIG. 5.

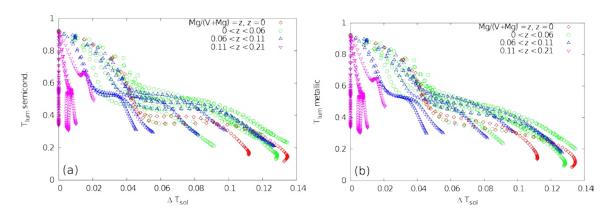


FIG. 6.

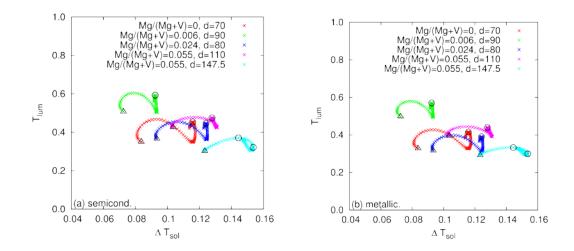
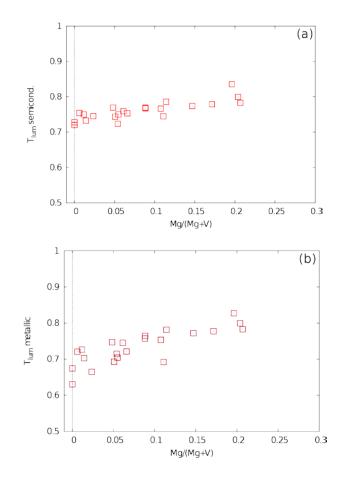


FIG. 7.



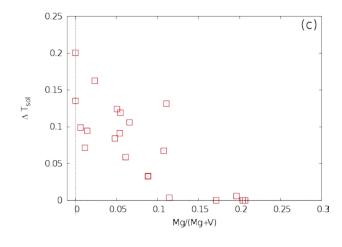
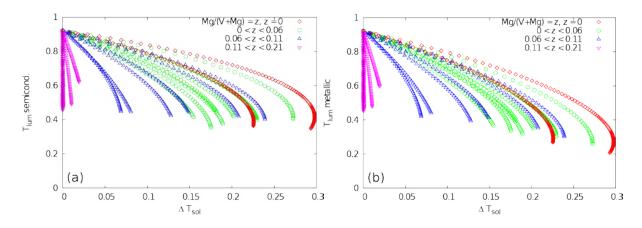


FIG. 8.





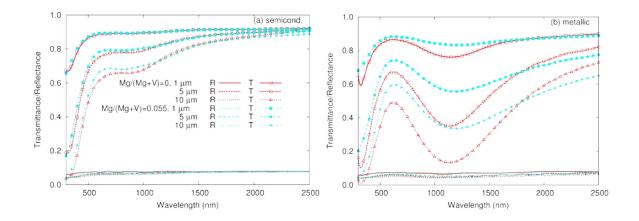


FIG 10.

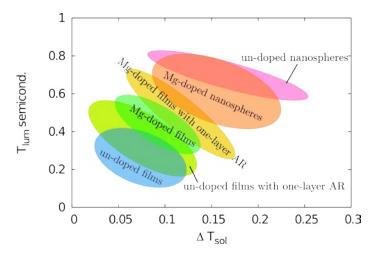


FIG. 11.